Record Nr. UNINA9910788729203321 Autore Whitehouse D. J (David J.) Titolo Handbook of surface and nanometrology / / David J. Whitehouse Pubbl/distr/stampa Boca Raton:,: CRC Press,, 2011 **ISBN** 0-429-14069-X 1-4200-8202-7 Edizione [2nd ed.] Descrizione fisica 1 online resource (982 p.) Altri autori (Persone) WhitehouseD. J (David J.). Disciplina 620/.440287 Surfaces (Technology) - Measurement Soggetti Nanostructured materials Metrology Lingua di pubblicazione Inglese **Formato** Materiale a stampa Livello bibliografico Monografia Rev. ed. of: Handbook of surface metrology. c1994. Note generali A Taylor & Francis book. Nota di bibliografia Includes bibliographical references and index. Nota di contenuto Front cover; Dedication; Contents; Preface; Acknowledgments; Chapter 1. Introduction-Surface and Nanometrology; Chapter 2. Characterization; Chapter 3. Processing, Operations, and Simulations; Chapter 4. Measurement Techniques; Chapter 5. Standardization-Traceability-Uncertainty; Chapter 6. Surfaces and Manufacture; Chapter 7. Surface Geometry and Its Importance in Function; Chapter 8. Surface Geometry, Scale of Size Effects, Nanometrology; Chapter 9. General Comments; Glossary; Back cover Sommario/riassunto David Whitehouse, known as the father of digital metrology, helped pioneer the use of nanotechnology in surface science and surface metrology, and he continues to move the field forward. In this heavily revised and expanded edition, he addresses the many paradigm shifts occurring in the field. He explains the incorporation of physics to develop optimum solutions for manufacture and performance, and provides mechanical engineers with accessible explanations of essential concepts along with the higher mathematics that is now required of

those working in the field. Emphasis is placed on systems w